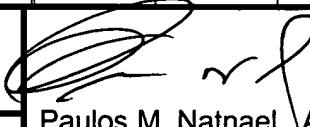


Issue Classification				Application/Control No.		Applicant(s)/Patent under Reexamination	
				09/487,729		HAN, BAIK-HEE	
				Examiner		Art Unit	
				Paulos M. Natnael		2614	

ISSUE CLASSIFICATION				
ORIGINAL		CROSS REFERENCE(S)		
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)	
348	732			
INTERNATIONAL CLASSIFICATION				
H	0	4	N	5/50
				/
				/
				/
				/
				
(Assistant Examiner) (Date)		Total Claims Allowed: 6		
 (Legal Instruments Examiner) (Date)		Paulos M. Natnael August, 2, 2005 (Primary Examiner) (Date)		
		O.G. Print Claim(s) 1		O.G. Print Fig. 2

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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